

<b>Notice of References Cited</b>	Application/Control No. 09/810,241	Applicant(s)/Patent Under Reexamination OHKAWA ET AL.	
	Examiner Hieu c. Le	Art Unit 2142	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,349,092	02-2002	Bisson et al.	370/258
*	C	US-5,550,805	08-1996	Takatori et al.	370/222
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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